V<sub>DS</sub> (V)

 $I_D(A)$ 

Configuration

Package

**PRODUCT SUMMARY** 

 $R_{DS(on)}(\Omega)$  at  $V_{GS} = -10 V$ 

 $R_{DS(on)}(\Omega)$  at  $V_{GS}$  = -4.5 V

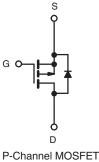
### P-Channel 60 V (D-S) 175 °C MOSFET

- TrenchFET<sup>®</sup> power MOSFET
- 100 %  $\rm R_g$  and UIS tested









ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	-60	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	v		
Continuous Drain Current	T <sub>C</sub> = 25 °C	I_	-36			
	T <sub>C</sub> = 125 °C	- I <sub>D</sub>	-21			
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	-60	А		
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	-100			
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	-36			
Single Pulse Avalanche Energy		E <sub>AS</sub>	64.8	mJ		
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	PD	68	W		
	T <sub>C</sub> = 125 °C	гD	22	۷V		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		
Soldering Recommendations (Peak Temperature) d, e			260	0		

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	68	°C/W	
Junction-to-Case (Drain)		R <sub>thJC</sub>	2.2	0/10	

#### Notes

- a. Package limited.
- b. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- c. When mounted on 1" square PCB (FR4 material).
- d. For DFN3X3, the end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.





DFN 3x3 EP



-60 0.0210 0.0288

-36

Single

DFN 3X3

	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static	1						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = -250 μA		-60	-	-	v
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$		-2.0	-2.5	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$		-	-	± 100	nA
		$V_{GS} = 0 V$	V <sub>DS</sub> = -60 V	-	-	-1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = -60 V, T <sub>J</sub> = 125 °C	-	-	-50	μA
		$V_{GS} = 0 V$	V <sub>DS</sub> = -60 V, T <sub>J</sub> = 175 °C	-	-	-150	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>GS</sub> = -10 V	$V_{DS} \ge -5 V$	-30	-	-	Α
		V <sub>GS</sub> = -10 V	I <sub>D</sub> = -10 A	-	0.0210	-	Ω
Drain-Source On-State Resistance <sup>a</sup>	R	V <sub>GS</sub> = -10 V	I <sub>D</sub> = -10 A, T <sub>J</sub> = 125 °C	-	0.0409	-	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V	I <sub>D</sub> = -10 A, T <sub>J</sub> = 175 °C	-	0.0504	-	
		V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -5 A	-	0.0288	-	
Forward Transconductance b	9 <sub>fs</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -10 A		26	-	S
Dynamic <sup>b</sup>	•	•					
Input Capacitance	C <sub>iss</sub>		V <sub>DS</sub> = -25 V, f = 1 MHz	-	2600	3400	pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$		-	310	450	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	200	275	
Total Gate Charge <sup>c</sup>	Qg			-	65	100	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>GS</sub> = -10 V	$V_{DS} = -30 \text{ V}, \text{ I}_{D} = -5 \text{ A}$	-	9.5	-	nC
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			-	19	-	
Gate Resistance	R <sub>g</sub>		f = 1 MHz	0.50	1.19	1.80	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			-	15	25	
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = -30 \text{ V}, \text{ R}_{\text{L}} = 6 \Omega$ $I_{\text{D}} \cong -5 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		-	5	10	ns
Turn-Off Delay Time c	t <sub>d(off)</sub>			-	40	75	
Fall Time <sup>c</sup>	t <sub>f</sub>			-	6	12	
Source-Drain Diode Ratings and Chara	acteristics <sup>b</sup>	•			·		
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	-100	Α
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = -10 A, V <sub>GS</sub> = 0 V		-	-0.80	-1.2	V

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

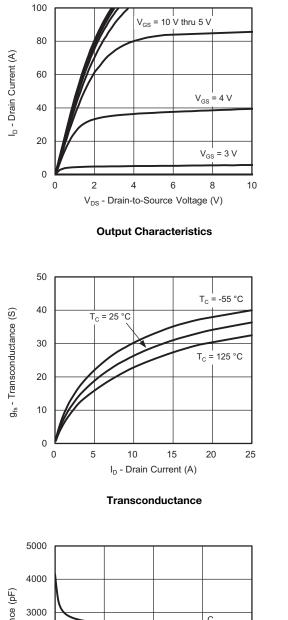
c. Independent of operating temperature.

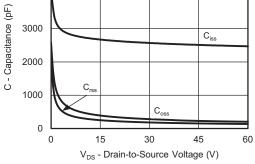
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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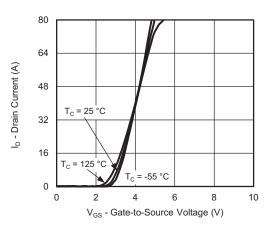


#### **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)

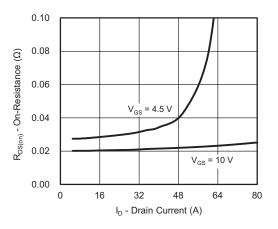




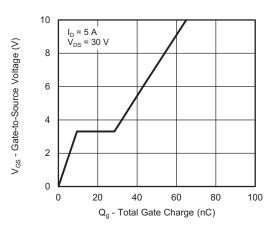
Capacitance



Transfer Characteristics



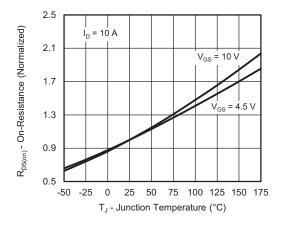
**On-Resistance vs. Drain Current** 



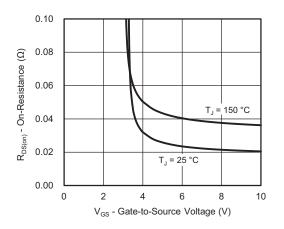
**Gate Charge** 



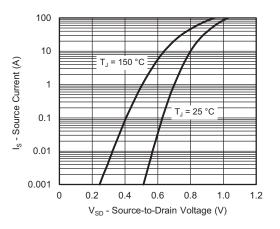
#### **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



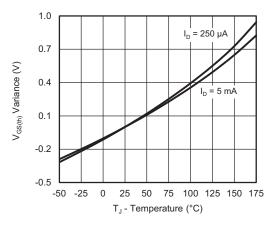
**On-Resistance vs. Junction Temperature** 



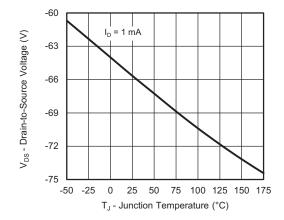
On-Resistance vs. Gate-to-Source Voltage



Source Drain Diode Forward Voltage



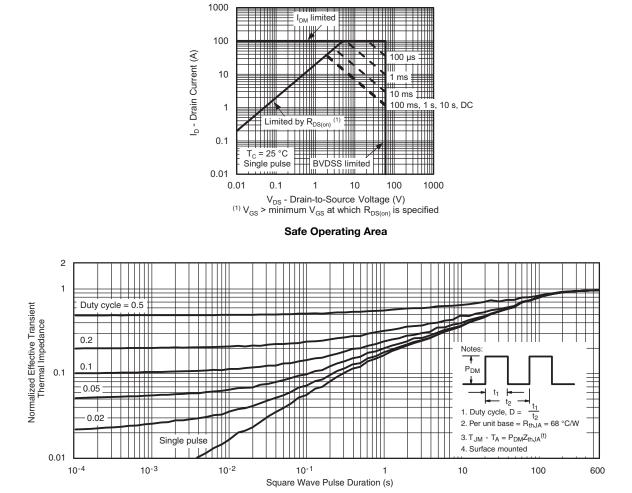




**Drain-Source Breakdown vs. Junction Temperature** 



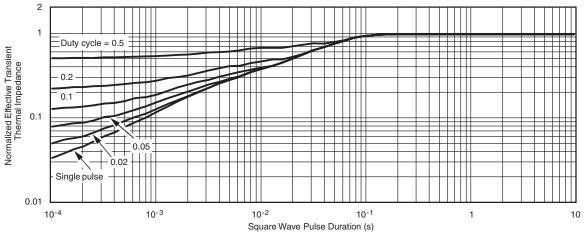
#### **THERMAL RATINGS** (T<sub>C</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



#### **THERMAL RATINGS** (T<sub>C</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

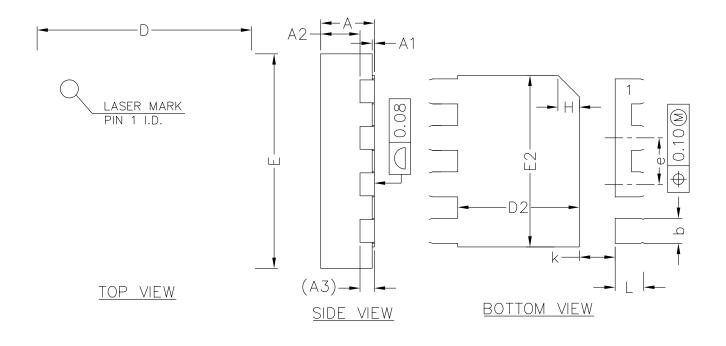
• The characteristics shown in the two graphs

- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.







<u>SIDE VIEW</u>

SYMBOL	MIN	NOM	MAX	
А	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
A3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
E	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
Κ	0.40	0.50	0.60	
L	0.35	0.40	0.45	

# COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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